L Number	Hits	Search Text	DB	Time stamp
3	12	(29/846,842,884).ccls. and (wet adj	USPAT;	2003/05/12 11:33
}		etching) and (probe or contact or	US-PGPUB;	2000,00,22 22.00
		electrode) and testing	IBM_TDB	
4	17	, the property and the day comming, and	USPAT;	2003/05/12 11:34
		(probe or contact or electrode) and	US-PGPUB;	
5	0	testing	IBM_TDB	0000/05/05
	1	(261/11).ccls. and (wet adj etching) and (probe or contact or electrode) and	USPAT; US-PGPUB;	2003/05/12 11:35
		testing	IBM TDB	
6	0	(261/11).ccls.	USPAT;	2003/05/12 11:34
			US-PGPUB;	2003/03/12 11.34
			IBM TDB	
7	266	(216/11).ccls.	USPAT;	2003/05/12 11:35
			US-PGPUB;	
		(016/11)	IBM_TDB	
8	9	(216/11).ccls. and (wet adj etching) and	USPAT;	2003/05/12 11:35
		(probe or contact or electrode) and testing	US-PGPUB;	
11	0	, -	IBM_TDB	2002/05/12 11:26
~~		(probe or contact or electrode) and	USPAT; US-PGPUB;	2003/05/12 11:36
		testing	IBM TDB	
12	65		USPAT;	2003/05/12 11:36
			US-PGPUB;	
			IBM_TDB	
-	1	5105537.pn.	USPĀT;	2003/05/09 11:01
	1		US-PGPUB;	
_	14	5105537.URPN.	IBM_TDB	2002/05/20 22
_	13	3103537.0RPN. ("3634807" "3725845" "3881799"	USPAT USPAT	2003/05/09 11:02 2003/05/09 11:04
	13	"4050756" "4208242" "4240198"	USPAT	2003/05/09 11:04
		"4253908" "4398994" "4604644"		
		"4644130" "4746399" "4751563"		
	İ	"4940510").PN.		
-	40	5220725.URPN.	USPAT	2003/05/09 11:08
-	33	("3293509" "3776752" "3789471"	USPAT	2003/05/09 11:17
		"3871008" "3970887" "3998678" "4163040" "4173013" "4173531"		
		"4163949" "4172912" "4178531" "4407695" "4513308" "4551649"		
		"4407695" "4513308" "4551649" "4663559" "4664748" "4685996"	:	
		"4701366" "4721885" "4818914"		
		"4857161" "4857799" "4901028"		
		"4902930" "4906840" "4912822"		
		"4940916" "4956574" "4983878"		
		"5019003" "5047830" "5064396"		
		"5105537" "5118299" "5137461").PN.		
-	1	("5753130").PN.	USPAT;	2003/05/09 11:21
			US-PGPUB;	
_ [16592	 wet adj etching	IBM_TDB USPAT;	2003/05/09 13:28
			US-PGPUB;	2003/03/03 13:28
			IBM TDB	
-	3784	sharp adj tip	USPAT;	2003/05/09 12:42
			US-PGPUB;	
			IBM_TDB	
-	15	sharp adj tip adj electrode	USPĀT;	2003/05/09 12:44
			US-PGPUB;	
_	350770	alastrada	IBM_TDB	0000/07/00
	350778	electrode	USPAT;	2003/05/09 12:43
			US-PGPUB; IBM TDB	
_	5051	(sharp or tip) adj electrode	USPAT;	2003/05/09 12:44
			US-PGPUB;	
			IBM_TDB	
-	415	((sharp or tip) adj electrode) and (etch	USPĀT;	2003/05/09 12:44
		or etching)	US-PGPUB;	
		//	IBM_TDB	
-	40	((sharp or tip) adj electrode) and (wet	USPAT;	2003/05/09 12:49
		adj (etch or etching))	US-PGPUB;	
			IBM_TDB	

_	13051	electrode and (wet adj (etch or etching))	USPAT; US-PGPUB;	2003/05/09 12:49
_	24	((projected or projection) adj electrode) and (wet adj (etch or etching))	IBM_TDB USPAT; US-PGPUB;	2003/05/09 12:49
_	72		IBM_TDB USPAT	2002/05/00 12:52
-	1	5105537.pn.	USPAT; US-PGPUB;	2003/05/09 12:53 2003/05/09 12:56
<u> </u>	14	5105537.URPN.	IBM_TDB USPAT	2003/05/09 12:56
-	13	("3634807" "3725845" "3881799" "4050756" "4208242" "4240198" "4253908" "4398994" "4604644" "4644130" "4746399" "4751563" "4940510").PN.	USPAT	2003/05/09 12:59
-	15		USPAT	2003/05/09 13:00
-	396		USPAT; US-PGPUB;	2003/05/09 13:04
_	38	29/884.ccls. and electrode	IBM_TDB USPAT; US-PGPUB; IBM TDB	2003/05/09 13:05
-	14		USPAT	2003/05/09 13:09
-	12436	(wet adj etching) and contact	USPAT; US-PGPUB; IBM TDB	2003/05/09 13:11
_	2080	(wet adj etching) and ((conductive or electrical) adj contact)	USPAT; US-PGPUB; IBM TDB	2003/05/09 13:12
_	14	(wet adj etching) and detachable and ((conductive or electrical) adj contact)	USPAT; US-PGPUB; IBM TDB	2003/05/09 13:13
_	1909	<pre>(wet adj etching) and (remove or removed or removable or detachable) and ((conductive or electrical) adj contact)</pre>	USPAT; US-PGPUB; IBM TDB	2003/05/09 13:14
_	140		USPĀT; US-PGPUB;	2003/05/09 13:23
_	7		IBM_TDB USPAT; US-PGPUB; IBM_TDB	2003/05/09 13:28
_	14		USPAT	2003/05/09 13:43
_	13	("3634807" "3725845" "3881799" "4050756" "4208242" "4240198" "4253908" "4398994" "4604644" "4644130" "4746399" "4751563" "4940510").PN.	USPAT	2003/05/09 13:27
-	1	<pre>(wet adj etching) and ((remove or removed or removable or detachable) with (conductive or electrical or testing) adj</pre>	USPAT; US-PGPUB; IBM_TDB	2003/05/09 13:30
		(tip))		
-	0	<pre>(wet adj etching) and ((remove or removed or removable or detachable) with (conductive or electrical or testing) adj (projection))</pre>	USPAT; US-PGPUB; IBM_TDB	2003/05/09 13:31
-	0		USPAT; US-PGPUB; IBM_TDB	2003/05/09 13:32
-	28	<pre>(wet adj etching) and ((conductive or electrical or testing) adj (pin))</pre>	USPAT; US-PGPUB; IBM TDB	2003/05/09 13:42
-	2	29/884.ccls. and (wet adj etching)	USPAT; US-PGPUB; IBM TDB	2003/05/09 13:42
_	1	5105537.PN.	USPAT	2003/05/09 13:43
_	60	205/667.ccls.	USPAT	2003/05/09 13:45
-	39		USPAT	2003/05/09 13:45
L <u>-</u>	5	205/667.ccls. and (wet adj etching)	USPAT	2003/05/09 13:46

-	1058	216/\$.ccls. and (wet adj etching)	USPAT	2003/05/09 13:47
-	831	216/\$.ccls. and (wet adj etching) and	USPAT	2003/05/09 13:47
		(probe or contact or electrode)		
-	69	216/\$.ccls. and (wet adj etching) and	USPAT	2003/05/09 13:48
		(probe or contact or electrode) and		
		testing		
-	44	4952272.URPN.	USPAT	2003/05/09 13:53
-	44	4952272.URPN.	USPAT	2003/05/09 13:55
-	48999	probe and testing	USPAT;	2003/05/12 09:52
		•	US-PGPUB;	
			IBM_TDB	
-	44	4952272.URPN.	USPAT	2003/05/12 09:52